

Notice of References Cited	Application/Control No. 10/577,105	Applicant(s)/Patent Under Reexamination KLEIN GUNNEWIEK ET AL.	
	Examiner HEE-YONG KIM	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,398,068 A	03-1995	Liu et al.	375/240.16
*	B	US-5,619,268 A	04-1997	Kobayashi et al.	375/240.15
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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